



ECSE 425 Lecture 3: Trends in IC Cost

H&P, Chapter 1

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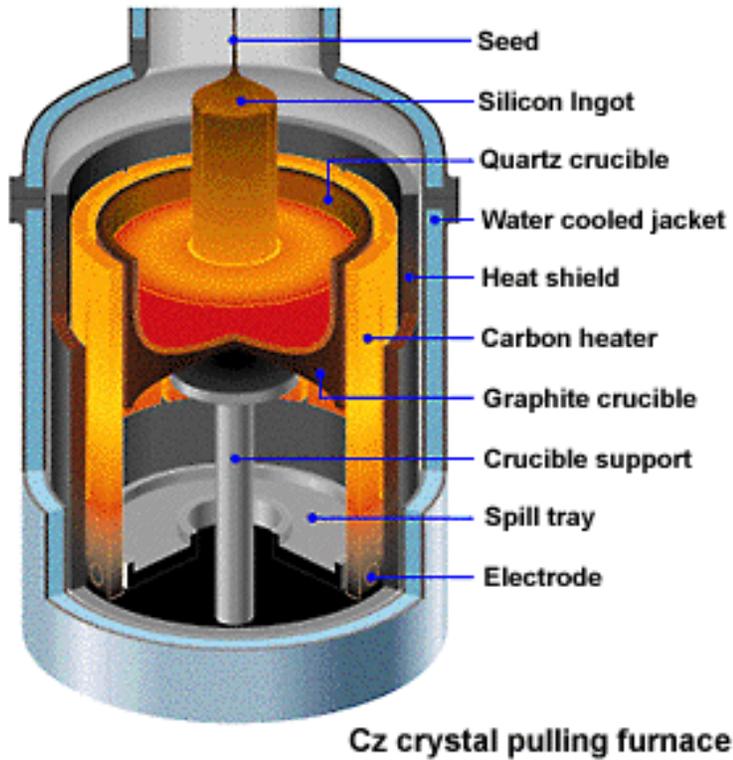
Last Time

- Computer architecture
- Trends so far
 - Performance
 - Bandwidth vs. latency
 - Power

Today

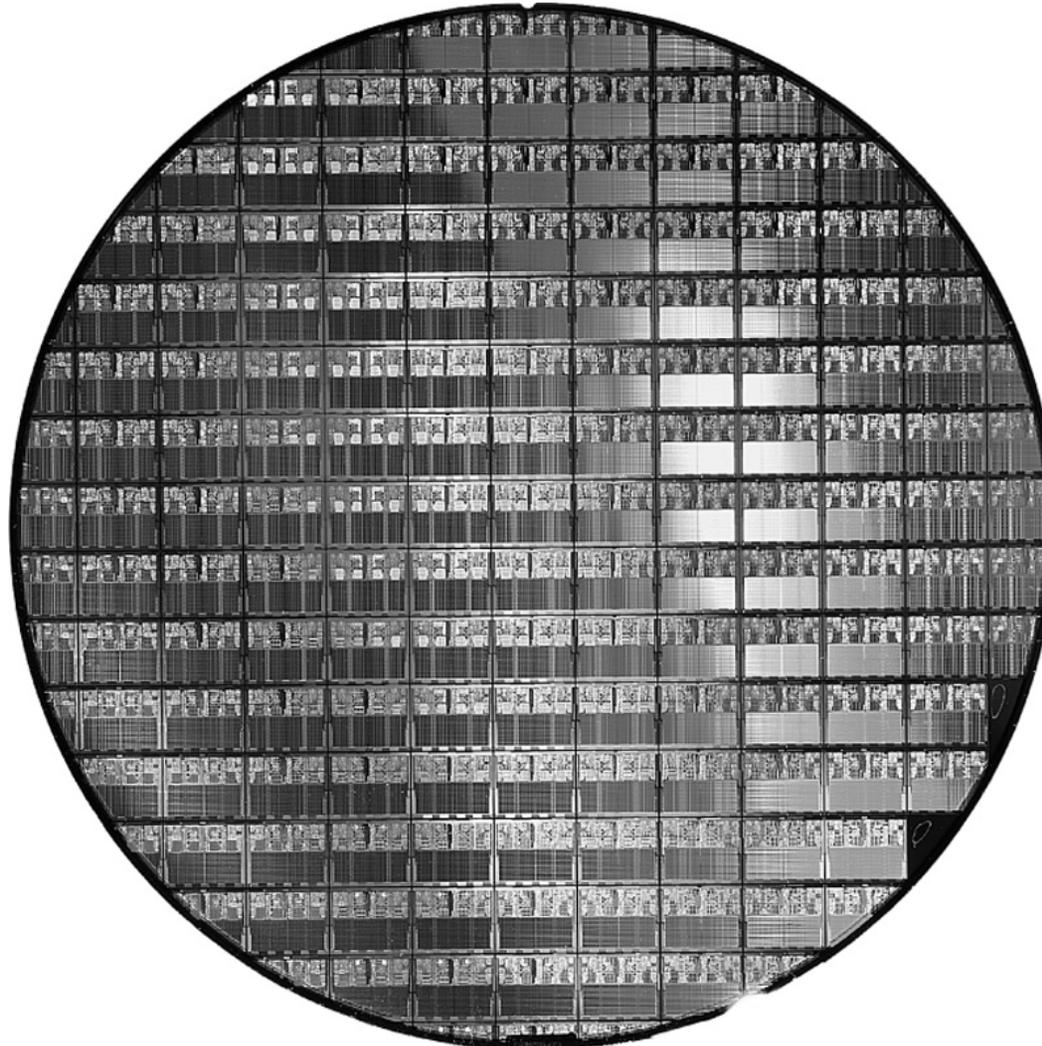
- Integrated Circuit (IC) Cost

Silicon: It All Starts Here



[Credit: Mission Silicon, Inc]

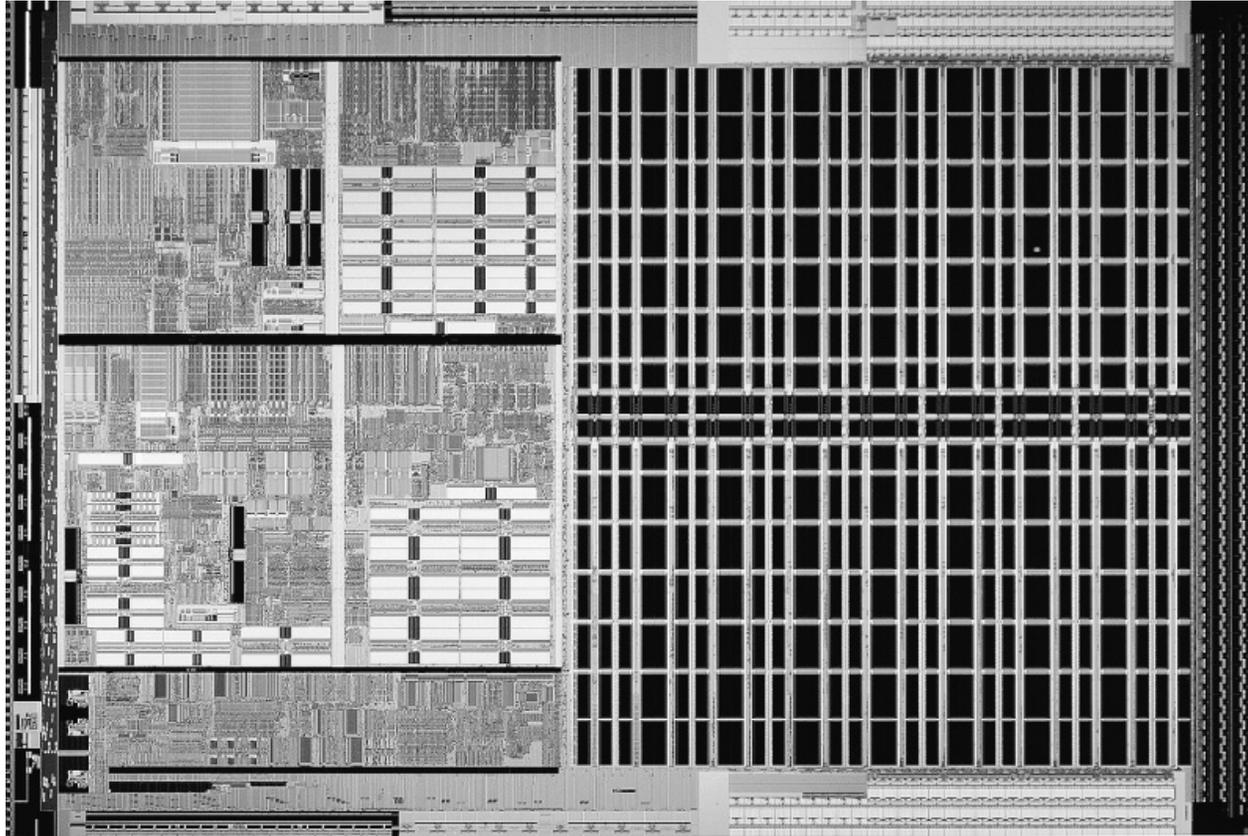
Processed Silicon Wafer



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300 mm AMD Opteron WAFER in 90nm process (117 processors)

Single Die



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AMD Opteron die

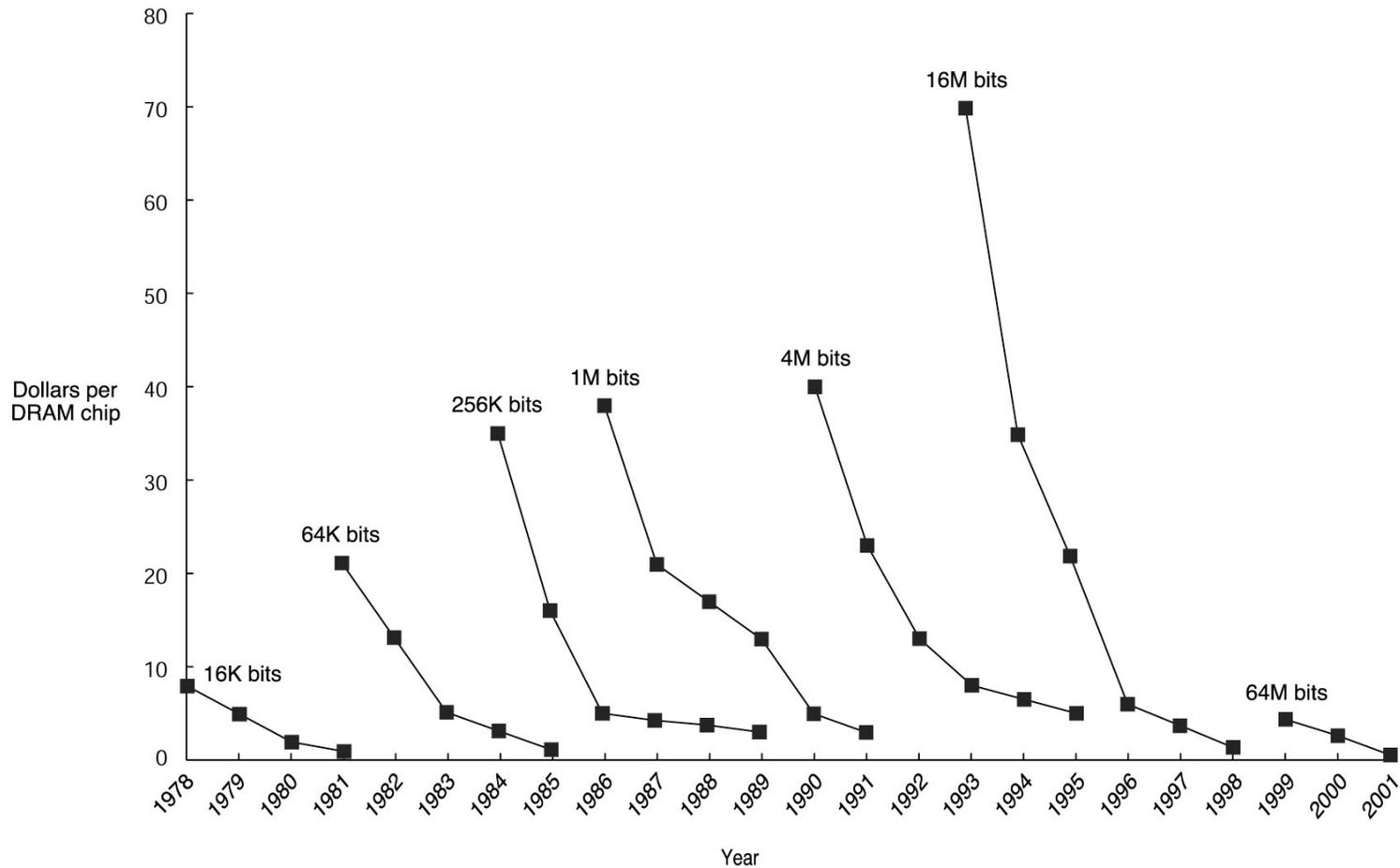
The Cost of IC Manufacturing

- Non-recurring expenses
 - IC mask set
- Recurring expenses
 - Cost of manufacturing, including raw materials
 - Cost of die testing
 - Cost of die packaging
 - Cost of manufacturing losses

Reducing the Cost of Computers

- Time: yield learning
 - Better yield
 - Lower manufacturing cost
- Manufacturing volume
 - As yield improves, increase volume
 - 10% cost decrease for doubling volume
- Commoditization
 - When all processors in a particular market are basically the same, costs are driven down
 - Low end computers (desktop, laptop)

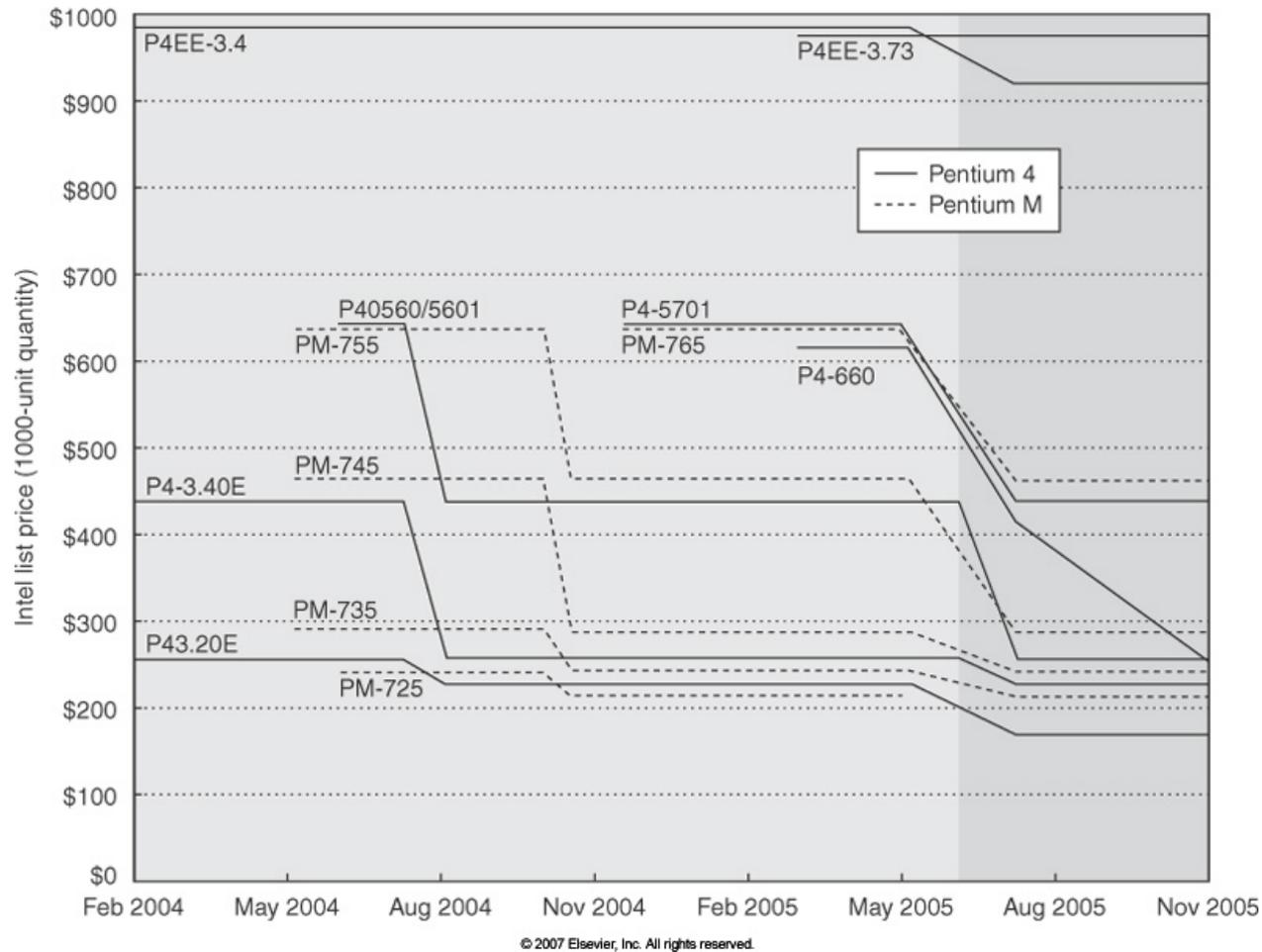
DRAM Cost Trends



Prices of six generations of DRAMs over time since 1977 in dollars

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Processor Cost Trends



Price of Pentium 4 and Pentium M at a given frequency decreases over time as yield enhancements decrease the cost of a good die and competition forces price reductions.

Quantifying IC Cost

$$ICCost = \frac{DieCost + DieTestCost + PackagingAndTestCost}{FinalYield}$$

$$DieCost = \frac{WaferCost}{DiesPerWafer \times DieYield}$$

$$DiesPerWafer = \frac{\pi \times WaferRadius^2}{DieArea} - \frac{\pi \times WaferDiameter}{\sqrt{2} \times DieArea}$$

$$DieYield = WaferYield \times \left(1 + \frac{DefectDensity \times DieArea}{\alpha} \right)^{-\alpha}$$

IC Cost Examples (1)

- Find the number of dies per 300 mm wafer for a die 1.5 cm on a side

IC Yield Examples (2): Case Study 1.1

Chip	Die Size (mm ²)	Defect Density (cm ⁻²)	Technology (nm)	Transistors (millions)
Sun Niagara	380	0.75	90	279
AMD Opteron	199	0.75	90	233

- What is the yield for the AMD Opteron?
 - $\alpha = 4$
- What is the yield for the Sun Niagara?
- Why does Niagara have worse yield?